




<p>Searched</p> 	<p>Application/Control No.</p> <p>10663046</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>GASPERI ET AL.</p>
	<p>Examiner</p> <p>Kaplan, Hal I</p>	<p>Art Unit</p> <p>2836</p>

Class	SubClass	Date	Examiner
178	18.02	09/20/2006	HK
361	181	09/20/2006	HK

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Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
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	Examiner Kaplan, Hal I	Art Unit 2836

Notes	Date	Examiner
340/644 (consulted Daniel Wu)	02/24/2006	HK
345/173; 178/18.01,18.06 (consulted Henry Tran)	02/24/2006	HK
361/179,181 (consulted Stephen W. Jackson)	02/24/2006	HK
EAST (US-PGPUB,USPAT,USOCR,FPRS,EPO,JPO,DERWENT,IBM_TD B) - See Search History Printout	09/20/2006	HK
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